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Rotating Scatter Mask Optimization for Gamma Source Location Identification

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Abstract

Rotating scattering masks have shown promise as a cheap, lightweight method for identifying the direction of a gamma emitting source. However, further examination of the current rotating scattering mask design shows that the identification could be improved by changing the geometry. Three methods are introduced to generate the mask geometry accompanied by the resulting detector response matrix analysis. The results demonstrate superior identification characteristics than the current design. Further possible design enhancements are discussed.

Keywords: RSM, geometry optimization, Hadamard, source direction

1. Introduction

Identifying a gamma source's location is important in a variety of situations such as providing security, treaty compliance, and locating orphan sources.

A novel alternative approach utilizes a mask placed over a position-insensitive detector [1]. The system records energy spectra as a function of the geometrically varying mask, which is accomplished through a constant rotation of the mask at a set rate. The spectra obtained depend on the source position and can be used to identify the source direction.

2. Background

The rotating scatter mask (RSM) concept offers many benefits over other gamma source position identification detectors. Specifically, it "provides a nearly 4π field-of-view, operates for a broad range of gamma energies, and has a relatively simple design [2]." This system uses a spherical reference system, where θ is the azimuthal and ϕ the polar angle. The mask works by attenuating and scattering the incoming particles in order to produce unique detector response curves (DRCs) [2]. To obtain the measurements for the position identification, the mask starts at an initial θ and ϕ position. It then rotates in θ around the detector with the signal recorded at each discrete θ position. The measured DRC is generated by summing the counts over a desired energy range for each θ position in one complete mask rotation. Comparing this curve with each possible DRC, which are known through experimentation or simulation, using a mean square error, least squares, or maximum likelihood estimate approach provides an identified initial source location.

FitzGerald introduced the RSM shown in Fig. 1 that has a 14 inch diameter and surrounds a 3 x 3 inch cylindrical NaI scintillating detector [1]. His original MCNP model contained 31 elements or one element every 11.6° . In order to increase the accuracy of the geometric representations, the angular resolution of the model was later increased to every degree.

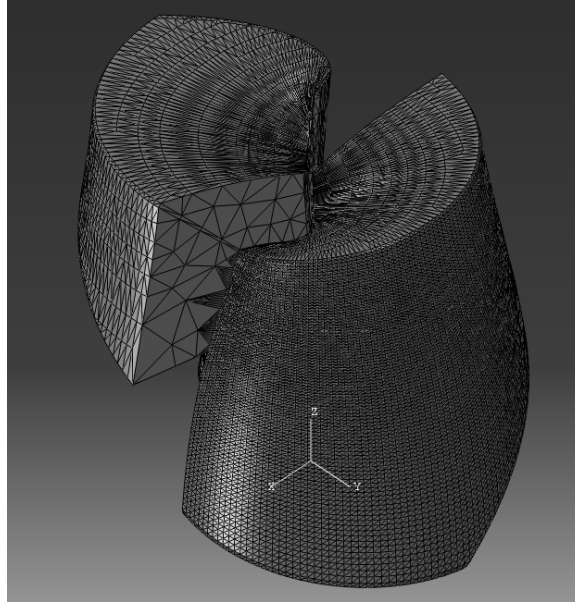


Figure 1. Isometric view of the unstructured mesh used to model the RSM in MCNP.

FitzGerald's design methodology assumes that the detector response is related to the mask geometry. Without this assumption, intentional mask design degenerates into random trial and error. In addition, he proposed three desirable characteristics for the RSM system. First, for any given initial source position, there is a unique response curve generated as the mask rotates 360° . This condition is necessary as a non-unique response would make at least two initial source position DRCs indistinguishable and unique identification impossible. The second characteristic requires the mask's average thickness over a 360° rotation to be a constant value for all ϕ s. This criteria prevents higher or lower average responses for different ϕ positions. This is not necessary to ensure the uniqueness of the DRC, however DRCs with widely varying average thicknesses may have a lower average count, which makes them more susceptible to measurement noise and increases the time required to obtain an accurate measured response. The final characteristic is for the solid angle from the detector centroid to be equal for all cells. This constraint provides the same spatial resolution in both azimuthal and polar directions. Not explicitly mentioned by FitzGerald is an assumption that the geometry should be continuous, thereby allowing the DRCs to be discretized as desired.

To improve upon the Fitzgerald design, methods were borrowed from the design of encoding masks is in the fields of spectrometry and imaging [3, 4, 5, 6], where similar work was done to produce a rotating encoding mask [7]. Fateley et al.[8] introduced the use of frequency information to identify spatial position information. Each of these methods is based on using a Hadamard matrix for the mask design.

3. RSM Design

3.1. Basic Model Setup

Logan et al.[2] showed statistical agreement between experimental and simulated DRCs using GEANT4. Thus, this work will use MCNP to simulate DRCs to evaluate the RSM performance for the designed developed. Instead of using just the full energy peak (FEP), the DRC is formed by adding all counts above 200keV to increase the efficiency of the determination of the source direction. This value was chosen as Logan et al. noted discrepancies for counts below approximately 200keV due to scatter in the environmental elements not considered in the model [2].

Originally, both the analysis of FitzGerald's RSM and the new designs were to be discretized into 10° increments in θ and 5° in ϕ . However, due to requirements for the Hadamard method, (which is discussed later) the proposed designs are broken into 32 discrete angles in θ resulting in $\Delta\theta = 11.25^\circ$ and $\Delta\phi = 5.625^\circ$ for 30 angles in ϕ .

The RSM design is to be optimized for a ^{137}Cs point source located at 36 inches from the center of the detector, mimicking Logan et. al's setup [2]. To simulate the relative source rotation in MCNP, the mask is stationary, while the source is rotated in spherical coordinates every degree for θ from 0 to 348.75° and for each ϕ from 5.625° to 168.75° . The modeled NaI detector includes a 1/8 inch 2024 Aluminum alloy sleeve on which the acrylic RSM is placed. The maximum diameter of the RSM depends on the methodology, but the maximum mask thickness is a constant 7.87 inches (20 cm). A sphere of air surrounds the source and detector. To increase the solution convergence rate, particles were emitted within a 27.26° half angle cone extending from the source to the detector's center. This variance reduction technique assumes that the effect of the few particles that scatter in the air outside of the cone, though the mask, and into the detector will have negligible contributions to the simulated DRCs. In addition, a 0.095 inch air gap between the mask and aluminum sleeve constrains the mask geometry from impinging on the sleeve and provides a space for grease to be applied between the moving parts. Finally, due to manufacturing constraints, each mask angle must have a non-zero thickness.

3.2. Design Assumptions and Limitations

It is assumed that the detector-mask-source geometry is related to the DRC and that geometry can be reconstructed using the DRC. Qualitative studies of this correlation showed that, in general, this assumption is valid with two qualifications. First, a discontinuous geometry results in a continuous DRC. To understand the next qualification, define a cell to be a rectangular prism with a given thickness extending from the centroid of the detector (outside of the aluminum sleeve) in a given direction. Since the cells do not have impenetrable walls, particles from one source position enter cells pointed at other positions. In fact, this phenomena is one of the desirable characteristics of FitzGerald's design as an increase in scattered particles can increase the total number of counts seen by the detector. Unfortunately, there is a corresponding limit to the spatial resolution. When the solid angle for a cell becomes too small, it is possible that the source does not resemble a point source, but a distributed source (which spans multiple cells) as neighboring cells also include a strong response.

To best enable source direction determination, a unique set of DRCs must be obtained. The complete set of DRCs for all rotations angles forms the design response matrix (DRM). The primary criterion for the design choice will be the design with the most unique DRM. To achieve this goal, the requirements for maintaining a constant spatial resolution in both spherical directions and requiring a continuous geometry are relaxed. However, to obtain a more constant response level a constant average thickness is maintained.

3.3. Design Methodologies

There are two general classes for the geometry creation. The first method assumes that both the initial θ and ϕ positions are to be identified. The second approach uses a geometric marker, which allows the initial location of θ to be calculated. This assumption simplifies the θ identification and removes the θ shift effects. Both of these classes create a two dimensional matrix, which is mapped as the mask thickness to three dimensional space using spherical coordinates.

3.3.1. Identifying θ and ϕ

To function properly, the optimal mask design would have unique DRCs so that no information is shared among the curves. This condition implies that the DRCs should be orthogonal to each other resulting in linearly independent curves. If one creates an n by m matrix where $m < n$ there are at most n linearly independent vectors. Thus, there are $n - m$ vectors, which make up the space not spanned by the matrix. For the mask, this matrix defines the geometry (and presumably the DRCs) for initial position $\theta = 0$. However, the design must be unique for over all initial θ s (θ shifts). Looking at one shift in θ , one would obtain an additional n by m matrix. This space would be spanned by n vectors, which for linear independence would need to be in the $n - m$ space. For this condition to be true, $n \leq n - m \rightarrow m \leq 0$, which is impossible as $m > 0$.

As a result, it is impossible to create linearly independent DRCs. So, the optimized design objective is to create a design with the least amount of linear dependence. The three following methods are tailored to create designs

for identifying both θ and ϕ with a low linear dependence. The eigenvector approach solves a mass normalized eigenvalue problem, the binary method uses patterns of ones and zeros to represent the geometry, and a modification of the Hadamard approach used for rotating encoding masks is explored.

3.3.2. Eigenvector Approach

The eigenvector approach creates a basis set, which may be used to define the geometry space. First, n k values are chosen, where k is the spring constant. These values are then placed in a stiffness matrix corresponding to the coupled spring-mass problem shown in Fig. 2. The mass is assumed to be normalized. This approach assumes there is additional coupling between nearby springs, which represents the spatial coupling among nearby ϕ positions on the RSM. Other methods of coupling could be introduced if desired.

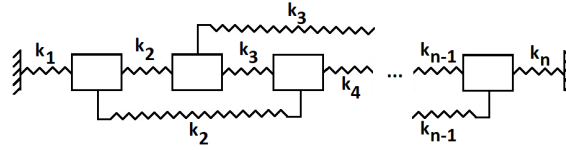


Figure 2. Equivalent spring-mass system used to generate the eigenvectors.

Note that the values chosen do not need to represent physical systems (e.g. negative stiffness values are acceptable). Other coupling systems were evaluated. However, the best results corresponding to the system show in Fig. 2.

Then, an eigenvalue problem is solved resulting in n orthonormal eigenvectors used to represent the geometry for initial position $\theta = 0$ and all initial ϕ positions. As the first vector tends to be planar motion (aka a cyclical vector) it is not chosen. This elimination results in a matrix formed by eigenvectors $2 \dots m + 1$. However, observations led to the conclusion that the orthogonal linear independence for $\theta = 0$ caused some high M values when considering all initial θ positions. Introducing linear dependence to the $\theta = 0$ matrix was seen to result in decreased M values for $\theta \neq 0$ combinations. To introduce linear dependence, a modified Gram-Schmidt orthogonality approach is used. Specifically,

$$\mathbf{E}_d^{new} = \mathbf{E}_d - c \sum_{e=1, \dots, n-1} \frac{\mathbf{E}_{e,e}^T \mathbf{E}_d}{\mathbf{E}_{e,e}^T \mathbf{E}_{e,e}} \mathbf{E}_{e,e}, \quad (1)$$

where d denotes the d^{th} eigenvector, c is a constant between 0 and 1 such that 0 adds no linear dependence and 1 adds a portion of all other $\mathbf{E}_{e,e}$ vectors, and $e = 1 \dots n - 1$ is the e^{th} left shift of eigenvector \mathbf{E}_e . Thus, the similar component of shifted versions of each other vector, $\mathbf{E}_{e,e}$, is subtracted from the basis ($\theta = 0$) vectors.

This formulation leads to a decrease in the M values, but an increase in the individual MAC values for the basis vectors as the non-shifted vectors are no longer orthogonal. Other combinations of eigenvectors and shifts for $\mathbf{E}_{e,e}$ are acceptable, however a shift is required due to the initial orthogonality (otherwise there is no similar portion to subtract).

Next, the average of each new eigenvector is subtracted from the corresponding vector. Since mask material may only be added, the minimum value (plus the 0.1 cm addition to the geometry) is added to the eigenvector to make all the thicknesses positive. Lastly, each eigenvector is normalized by the maximum vector value and scaled. These steps produce a minimal thickness of approximately 0.1 cm and a maximum mask thickness of 20 cm.

Multiple geometries for various k and c combinations can be tested resulting in the design surface shown in Fig. 3. These results are based solely on the geometry vectors and not \mathbf{DRM}_{red} . Using this information, the k and c combination with the lowest M value can be chosen for the more time expensive MCNP simulations.

3.3.3. Binary Approach

The binary approach uses ones and zeros to represent the geometry thickness. Notice that the mask's cyclic nature causes vectors such as $[1 \ 1 \ 0 \ 0]$ to be the same as $[1 \ 0 \ 0 \ 1]$ where the first vector is the second shifted by one entry to the right. If the design uses binary pattern such as these two, the DRCs for two initial positions will be identical. It can be proven for $n > 7$ the best solution is to have any combination of vectors with three ones placed in an arrangement

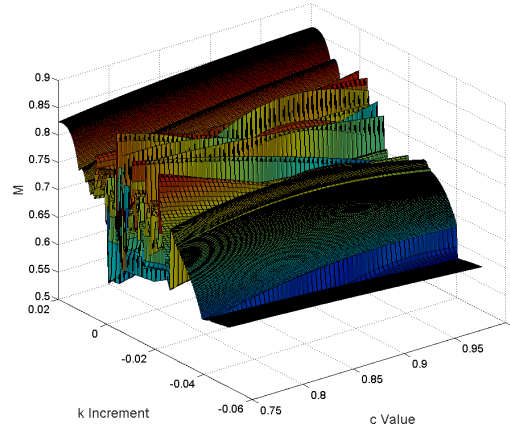


Figure 3. Design surface generated by different k step increments and c values used to minimize M .

that avoids cyclic behavior with themselves (such as $[1\ 0\ 1\ 0\ 1\ 0]$) or others (such as $[1\ 1\ 1\ 0\ 0\ 0]$ and $[0\ 1\ 1\ 1\ 0\ 0]$). The one exception is the inclusion of the binary "1" vector represented using 6 bits as $[0\ 0\ 0\ 0\ 0\ 1]$. These requirements yield the minimum possible M value of $4/9$ for any combination of binary geometry. For $n = 32$, there are many possible basis vectors; especially considering that the vectors can be shifted left or right (corresponding to multiplication or division by 2), and the ϕ vector order (1st, 2nd, 3rd, etc) may be swapped. This flexibility allows one to create unique geometries, mechanically balance the mask, or improve the likelihood of obtaining a signal given a random source position by more evenly spreading the ones and zeros around the mask.

3.3.4. Decoupling θ and ϕ

An alternative approach introduces additional material to create a low measurement "dead" zone at a consistent θ position. As a result, the initial θ position is assumed to be the angular distance difference between the start of the measurement and the minimum measurement location. The sign of the angle depends on the mask's rotation direction. It is conjectured that this association will be valid except when there are multiple sources in which spectral stripping is not possible or for distributed sources. Further work in this area is ongoing.

As the initial θ position is known, the reference DRM angle may be changed to the known θ position by shifting the basis matrix entries by the corresponding index number. This knowledge decouples the θ and ϕ identification, resulting in only needing to compare the measured DRC to the m ϕ curves in \mathbf{DRM}_{red} . Using this method, it is possible to create m linearly independent geometric basis vectors.

One such linearly independent basis is the Hadamard matrix. While this matrix has been used in spectroscopy for many years, Hadamard encoding masks assume that some of cells are "on", "off" or detected by a second sensor [6]. In addition, it is assumed that one knows the on/off state of the cells. The equivalent RSM design goal is to identify this on/off state and thus, it corresponds to an inverse problem. In contrast to the encoding masks, each cell in the RSM design is not in a fully on/off state, but may have particles passing through it even when the source is not directly aligned.

The Hadamard matrix is thought to only exist for square matrices where n is 1, 2, or divisible by 4 [3]. By construction, the mask design under consideration is discretized in order to have $n = 32$. Also, a Hadamard matrix has ones and negative ones. To convert it to a binary pattern, the negative one entries were changed to zeros. In order to create the "dead" zone, the vector of ones corresponding to $\theta = 0$ were changed to twos. A normalized geometry resulted by following the same steps as outlined in the eigenvector approach.

3.4. Design Evaluation

To assess the design optimality, three criteria relevant to the performance of the RSM are proposed. The first is the modal assurance criterion (MAC), which is a normalized number that indicates the similarity between two vectors [9].

A MAC value of zero indicates the two vectors are orthogonal, while a value of one indicates that they are identical. For this application, it is desirable that the curve generated at each initial source position be orthogonal - a.k.a. unique - to the others. Let this curve be denoted $\mathbf{DRC}_{i,j}$, where $i = 0, 1, \dots, n$ is the initial θ and $j = 0, 1, \dots, m$ is the initial ϕ index relative to a reference location on the mask. Since the mask rotates, the i^{th} DRC will be identical to the k^{th} DRC shifted by $k - i$ indices. A negative number corresponds to a shift to the left and a positive number a shift to the right. This property greatly impacts the mask design as any periodic vector with respect to θ will then result in duplicate i and k DRCs. The duplication due to periodicity would fail to meet the design's uniqueness requirements.

Logan's work established a connection between the measured and the simulated DRCs. Thus, assuming the measured response can be represented by the simulated spectrum, it is possible to analyze the uniqueness of the design by comparing each DRC with every other possible DRC to find the worst and average performance. Eqn. 2 defines the MAC number as

$$MAC_{i,j,k,l} = \frac{(\mathbf{u}_{i,j}^T \mathbf{v}_{k,l})^2}{(\mathbf{u}_{i,j}^T \mathbf{u}_{i,j})(\mathbf{v}_{k,l}^T \mathbf{v}_{k,l})}, \quad (2)$$

where $\mathbf{u}_{i,j}$ and $\mathbf{v}_{k,l}$ are the DRCs for the respective initial positions ($\theta = i\Delta\theta, \phi = j\Delta\phi$) and ($\theta = k\Delta\theta, \phi = l\Delta\phi$).

Considering the vector shifts, the maximum MAC number, which corresponds to the most similar pair of DRCs, and the average MAC number are given in Eqns. 3 and 4 respectively.

$$M = \max_{i,j,k,l} (MAC_{i,j,k,l}), \quad (3)$$

where $i \neq k$ and $j \neq l$.

$$A = \frac{1}{b} \sum_{i,j,k,l} (MAC_{i,j,k,l}), \quad (4)$$

where $i \neq k, j \neq l$, and b is the total number of combinations given by $b = \binom{m}{2} + (n-1)\binom{m+1}{2}$. Note that $\binom{m}{2}$ is the total number of combinations without θ shifts (aka $\theta = 0$), $n-1$ is the total number of θ shifts possible, and $\binom{m+1}{2}$ is the number of combinations for DRCs shifted one θ position. For the $n = 32$ and $m = 30$ mask design, $b = 14850$. An examination of Eqn. 3 shows that a bias in vectors u and v will result in a non-zero M value. Thus, the DRCs are normalized such that each one is zero mean over θ . These normalized DRCs form the reduced DRM or $\mathbf{DRM}_{\text{red}}$. Note that the average, minimum, and maximum MAC evaluations remain the same for different initial θ values. Thus, no θ shifting needs to be considered in the following formulations. The optimal design should have low M and A values.

The second criteria measures the RSM's efficiency. A high-efficiency design produces more accurate results in less measurement time, an important factor to consider for the intended applications of the RSM. This is calculated as

$$C = \frac{\sum_{i,j} \mathbf{DRM}_{\text{red}}}{n m}, \quad (5)$$

where n is ??? and m is ???. Note, this is not the absolute detection efficiency as the spectra obtained remove the γ 200 keV counts.

The final evaluation criterion focuses on the design's sensitivity (ability to create large variations in DRCs). The ratio of the maximum to minimum response in Eqn. 6 provides information on the relative amount of measurement time required and the measurement's sensitivity to random measurement noise.

$$S = \min_j \left(\frac{\max_i [\mathbf{DRM}_{\text{red}}]}{\min_i [\mathbf{DRM}_{\text{red}}]} \right) \quad (6)$$

The following section applies these four evaluation criteria to DRC simulations for all possible discrete source positions for the designs generated from the three approaches outlined in Sec. 3.3.

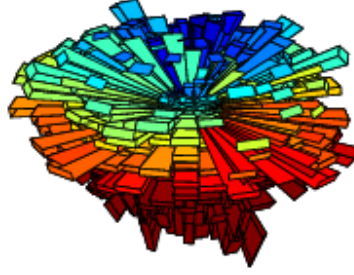


Figure 4. RSM geometry created by the eigenvector approach.

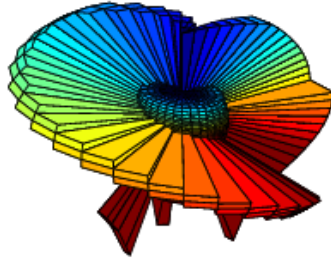


Figure 5. RSM geometry created by the binary approach.

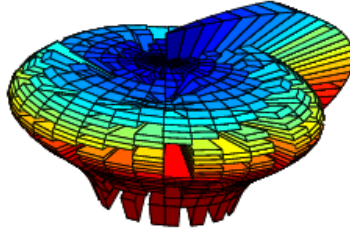


Figure 6. RSM geometry created by the Hadamard approach.

4. Results and Analysis

The proposed design methodologies produced the geometries shown in Figs. 4 to 6.

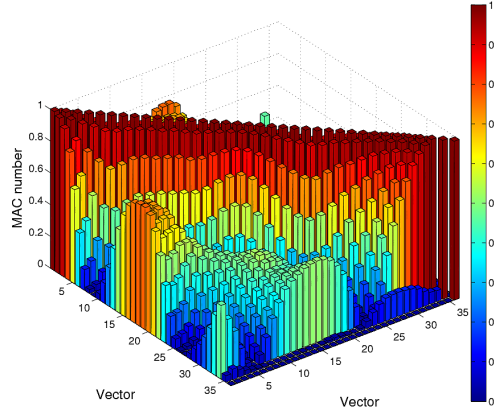
The binary pattern was constructed to have a fin that spirals around the mask. As it is not possible to have the fin completely cover the mask geometry, four other vectors were added to create the necessary basis.

The eigenvector approach used 32 k values from 0.1 to -0.2999 in increments of -0.0129. c was determined to be 0.999 from minimization of the design surface depicted in Fig 3. Other coupled systems did not have an optimal c value close to one.

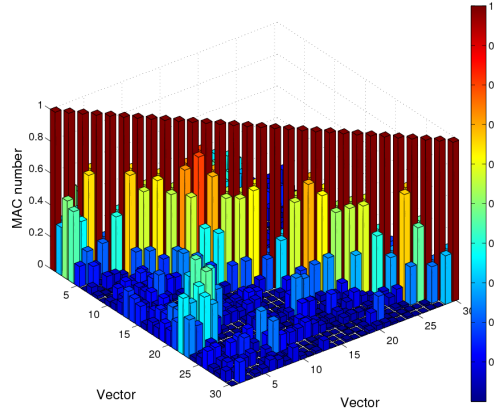
The FitzGerald's RSM was used as a baseline to establish design improvement for the RSM designs shown in Figs. 4 to 6. The simulation of FitzGerald's design involved a mask discretization of 10° in θ and ϕ ; corresponding to $n = 36$, which differed from the $n = 32$ used for the proposed designs as the Hadamard $n = 36$ matrix cannot be created by lower order Hadamard matrices [10]. This change in discretization will only have a minor impact to the evaluation criteria as the discretizations are sufficiently coarse to avoid the spatial resolution limit for a single point source.

Figure 7 shows a visual MAC number representation for $\theta = 0$ obtained by using Eqn. 2.

It is worth pointing out a couple of key features for these MAC plots. First, the diagonal entries correspond to comparing a vector to itself, and thus will always be equal to one. Second, the plots are symmetric about the

Figure 7. Representation of the Fitzgerald RSM MAC numbers for $\theta = 0$.

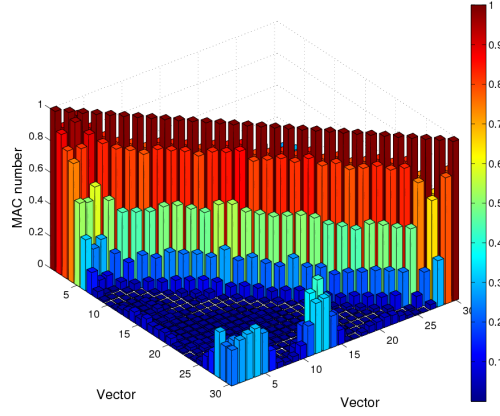
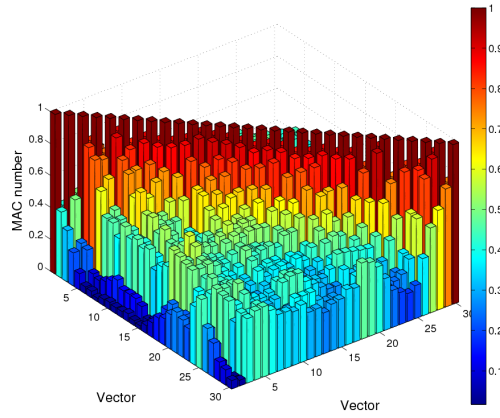
diagonal. Finally, the large off-diagonal regions are of particular interest because these high values could result in the mis-identification of the initial source direction. The new proposed designs significantly lower off-diagonal values resulting in less degeneracy in the source direction as shown in Figs. 8 to 10.

Figure 8. Eigenvector RSM MAC values for the basis $\theta = 0$.

The adjacent off-diagonal terms in Figs. 7, 9, and 10 show that there is a limit to the spatial resolution. Specifically, vectors p , $p + 1$, $p + 2$, and $p + 3$ have MAC numbers that incrementally decrease indicating that information is shared by neighboring initial positions. In the presence of measurement noise, it may only be possible to identify the position to an accuracy that is a multiple of the θ or ϕ discretization.

The off diagonal terms for the binary design are indicative of the limits of the design approach pursued. Since a full optimization was not performed, it is likely that the binary design can be improved by replacing the last four vectors with alternatives. This could result in a more rapid decrease close to the diagonal thereby improving the performance characteristics of this design class.

Table 1 summarizes the evaluation results for the original RSM, binary, eigenvector (EV), and Hadamard approaches. Recall that the Hadamard values correspond to those obtained without shifting vectors since the initial θ position can be deduced.

Figure 9. Binary RSM MAC values for the basis $\theta = 0$.Figure 10. Hadamard MAC numbers for the basis $\theta = 0$.

Notice that the original design has an overall MAC number of 1.00. This value corresponds to a part of the geometry that has a constant thickness as θ varies. As a result, a shift in the initial θ produces the same DRC and a MAC number of 1. For the same reason, the sensitivity value is 1.00. In contrast, the proposed methods have lower M values with the most desirable corresponding to the eigenvector approach. The Hadamard method produces vectors which on average share 42.3% of their information, which is more than the original design. The rapid change between ones and zeros coupled with the spatial resolution limits make the Hadamard method non-ideal for this problem. The lowest average MAC number corresponds to the eigenvector approach with only 6.63% similarity. These results indicate that the method that produces the most unique DRCs is the eigenvector approach. However, the trade-off is that the eigenvector method produced a RSM with a lower average normalized number of counts per cell. The binary method has the most average normalized number of counts per cell, but also the highest sensitivity. This high sensitivity may indicate that certain initial positions are more susceptible to measurement noise.

Table 1. Evaluation criteria comparisons from the original design and the three proposed designs from this work.

Criteria	Fitzgerald	EV	Binary	Hadamard
M	1.00	0.808	0.963	0.935
A	0.210	0.0663	0.125	0.423
$C (\times 10^{-4})$	3.75	2.96	3.86	3.70
S	1.00	1.07	1.16	1.07

5. Conclusions

Rotating scattering masks (RSMs) have shown promise for identification of a gamma source's direction, but previous results indicate that the original RSM design has degenerate detector response curves. This degeneracy may result in an incorrect source position identification, especially when considering noise, finite count times, and statistical confidence intervals. To improve upon the current state-of-the-art, this work introduced three methods to optimize RSM geometry to limit the mis-identification of a gamma source direction.

The eigenvector approach produced the most unique detector response curves when compared to the original Fitzgerald RSM and other proposed methodologies. Unfortunately there is a corresponding decrease in the average normalized counts per cell. The eigenvector mask requires 21% more particles and, therefore, longer measurement times to produce the same statistical accuracy as the original design.

While these results demonstrate the binary and eigenvector methods decrease the overall and average linear dependence of the DRCs, the full design space was not explored and more optimal designs may exist. Specifically, choosing an alternative last four vectors for the binary pattern may reduce the corresponding off-diagonal MAC terms. As a result, A should decrease. In addition, rotating or swapping the binary vectors would allow for a better mechanical balance. The eigenvector approach has a large design space especially when other coupled systems are considered. Further exploration of this space and its refinement may produce a geometry with lower M and A values.

6. Acknowledgment

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Appendix A. Proof

Goal: Choose n binary numbers such that the MAC number denoted as

$$MAC_{a,b} = \frac{(\mathbf{a} \cdot \mathbf{b})^2}{(\mathbf{a} \cdot \mathbf{a})(\mathbf{b} \cdot \mathbf{b})} \quad (\text{A.1})$$

is minimized for every combination of numbers a and b including their the corresponding cyclically shifted versions.

Consider an n bit binary number greater than zero with p ones and $n - p$ zeros, where $0 < p < n$. Further, shift this number by any number of bits so that the left-most bit contains a one. Because of the cyclic nature, the binary number can be written as a vector containing the integer number of zeros bounded on either end by ones. For example, the number 0 1 1 would be shifted to 1 0 1 and could be written as the vector [1]. Also, the number [0 1 0 1 0 1 0 0] can be shifted to [1 0 1 0 1 0 0 0], and the corresponding vector is [1 1 3]. Recall that the vector's cyclic nature causes the last one to wrap around to the first position. In general, we can write any non-zero binary number as the vector $\mathbf{v} = [v_1 \ v_2 \ v_3 \ \dots \ v_p]$, where each v_i is the number of zeros between two ones and $v_p = n - p - \sum_{i=1}^{p-1} v_i$.

Now, cyclic redundancy can be avoided by ignoring any \mathbf{v} that become duplicated under shifts. For example, [0 3 2] and [3 2 0] represented the same binary number, where the second vector is the first shifted to the left by $v_1 + 2$

bits. To avoid this behavior, we require $v_1 < v_p$, but $v_2 \leq v_p, v_3 \leq v_p, \dots, v_{p-1} \leq v_p$. Note that by construction two vectors with a different number of ones cannot be cyclically identical.

Consider two vectors, $\mathbf{u} = [u_1 \ u_2 \ u_3 \ \dots \ u_{p_u}]$ and $\mathbf{v} = [v_1 \ v_2 \ v_3 \ \dots \ v_{p_v}]$ containing p_u and p_v ones respectively. If $u_i = v_i$ the vector has at least two ones in the corresponding binary number that would align for some shift of \mathbf{u} . We want to choose n vectors, which a_1, a_2, \dots, a_n that produce the minimum value of $\max\{MAC_{a_1 \dots a_n}\}$, where the maximum is taken over all possible shifts of $\mathbf{a}_i, \mathbf{a}_j$, $i = 1 \dots n$, and $j = 1 \dots n$. Note that if $i = j$, then the second vector must be shifted by at least one bit to avoid comparing a vector with itself. For a binary number undergoing all possible shifts, the denominator becomes $p_u * p_v$, while the numerator is the square of the total number of ones that simultaneously align as each vector is rotated. As the number of ones increases, both the numerator and denominator increase. Thus, it becomes unclear if the MAC number increases or decreases as p_u and/or p_v increase.

First, consider $p = 1$. There is only one vector, which can be expressed as $[n - 1]$. There are no other possible non-cyclically redundant combinations. Letting a and b be this vector results in a maximum MAC number of $\frac{0}{1*1} = 0$.

Next, consider $p = 2$. Possible vectors include $[0 \ n - p], [1 \ n - p - 1], [2 \ n - p - 2], \dots, [\frac{n-p-1}{2} \ \frac{n-p+1}{2}]$ if n is odd or a limit of $[\frac{n-p}{2} - 1 \ \frac{n-p}{2} + 1]$ if n is even. Note that there are only $\frac{n-p+1}{2}$ if n is odd and $\frac{n-p}{2}$ if n is even possible vectors of type $p = 2$, but n are required. Thus, more vectors from other p types would be required to complete the basis set. By construction, all of the indices are unique indicating that only one 1 aligns over all possible rotations (if two aligned, then the vectors would in fact be identical). Thus, the maximum MAC number, when using any two $p = 2$ vectors is $\frac{1^2}{2*2} = 1/4$.

Consider $p = 3$. Let $m = \lfloor \frac{n-p-1}{p} \rfloor$, $q = \lfloor \frac{n-p}{2} \rfloor$, and s is 0 if n is odd and 1 if n is even. The possible vectors are sets of decreasing size

$$\begin{aligned} & \{[0, 0, n - p - 0]; [0, 1, n - p - 1]; \dots [0, q - 0, q + s - 0]\}, \\ & \{[1, 0, n - p - 1]; [1, 1, n - p - 2]; \dots [1, q + s - 1, q - 0]\}, \\ & \{[2, 0, n - p - 2]; [2, 1, n - p - 3]; \dots [2, q - 1, q + s - 1]\}, \\ & \{[3, 0, n - p - 3]; [3, 1, n - p - 4]; \dots [3, q + s - 2, q - 1]\}, \\ & \{[4, 0, n - p - 4]; [4, 1, n - p - 5]; \dots [4, q - 2, q + s - 2]\}, \\ & \vdots \\ & \{[m, 0, n - p - m]; [m, 1, n - p - m - 1]; \dots [m, q - \lfloor \frac{m+1}{2} \rfloor + s \bmod(m, 2), q - \lfloor \frac{m}{2} \rfloor + s \bmod(m + 1, 2)]\}, \end{aligned}$$

In general, the k th set can be expressed as

$$\{[k, 0, n - p - k]; [k, 1, n - p - k - 1]; \dots [k, q - \lfloor \frac{k+1}{2} \rfloor + s \bmod(k, 2), q - \lfloor \frac{k}{2} \rfloor + s \bmod(k + 1, 2)]\}, \quad (\text{A.2})$$

where the total number of terms, t_1 , is

$$t_1 = \sum_{k=0}^m \lfloor \frac{n-p}{2} \rfloor - \lfloor \frac{k+1}{2} \rfloor + s \bmod(k, 2) + 1. \quad (\text{A.3})$$

Since $v_1 < v_3$, sets with $v_1 > m$, can be expressed using the following approach,

$$\begin{aligned} & \{[m + 1, 0, n - p - m - 1]; [m + 1, 1, n - p - m - 2]; \dots [m + 1, n - p - 2m - 3, m + 2]\}, \\ & \{[m + 2, 0, n - p - m - 2]; [m + 2, 1, n - p - m - 3]; \dots [m + 2, n - p - 2m - 5, m + 3]\}, \\ & \{[m + 3, 0, n - p - m - 3]; [m + 3, 1, n - p - m - 4]; \dots [m + 3, n - p - 2m - 7, m + 4]\}, \\ & \vdots \\ & \{[\lfloor \frac{n-p-1}{2} \rfloor, 0, q + 1]\} \text{ if } n \text{ is even.} \\ & \{[\lfloor \frac{n-p-1}{2} \rfloor, 0, q + 1]; [\lfloor \frac{n-p-1}{2} \rfloor, 1, q]\} \text{ if } n \text{ is odd.} \end{aligned}$$

In general, the k th set can be expressed as

$$\{[k, 0, n - p - k - 0]; [k, 1, n - p - k - 1]; \dots [k, n - p - 2k - 1, k + 1]\}, \quad (\text{A.4})$$

where the total number of terms, t_2 , is

$$t_2 = \sum_{k=m+1}^{\lfloor \frac{n-p-1}{2} \rfloor} n - p - 2k - 1 + 1 = \sum_{k=m+1}^{\lfloor \frac{n-p-1}{2} \rfloor} n - p - 2k \quad (\text{A.5})$$

Thus, the total number of terms for n and $p = 3$ is $t = t_1 + t_2$.

Let the matrix \mathbf{V} contain terms $V_{ij} = v_i$ for the j th basis vector including the dependent v_p , where $1 < i < p$ and $1 < j < n$.

For a given n and p , the number of unique indices is less than or equal to $\lfloor \frac{n-p}{2} \rfloor + 1$ since $v_i \leq v_p$. To form an n vector basis requires $n(p-1)$ total entries. Thus, it is not possible for any column in \mathbf{V} to contain only unique indices since $n > \lfloor \frac{n-p}{2} \rfloor + 1$ and $r \geq 1$ for $p \geq 2$. Also, it is impossible to form a complete basis for $p = 2$. In addition, for $p = 3$ the maximum MAC number is $\frac{2^2}{3 \times 3} = 4/9$, where one duplicate index results in two aligned 1s.

Note that the $p = 1$ vector can be combined with the $p = 3$ vectors, since the maximum MAC number between a $p = 1$ and $p = 3$ vector is $\frac{1^2}{1 \times 3} = 1/3 < 4/9$ (only one “1” can align). Figure A.11 shows that the number of possible terms (including $p = 1$) equals n ($n = 8$) or exceeds n ($8 < n \leq 360$). Due to manufacturing constraints, n was limited to 360 as this corresponds to one degree increments in θ and 0.5 degree in ϕ . As a result, a full basis can be formed from these vectors if $n > 7$.

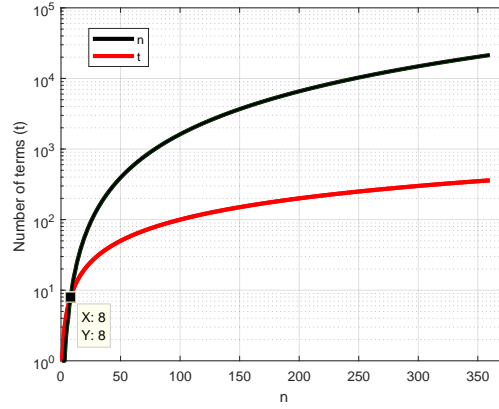


Figure A.11. The number of possible terms for $p = 1$ and 3 equals or exceeds n if $n > 7$.

Now, consider creating a $p > 3$ basis. Let r represent the greatest number of repeated indices for any two basis vectors. Note that the minimum number of aligned 1s is $r + 1$. The maximum MAC number can then be expressed as

$$MAC_{a,b} \geq \frac{(r+1)^2}{p_a p_b}, \quad (\text{A.6})$$

where p_a and p_b are the p -type of vectors a and b respectively. If one chooses vectors from the same p -type, then $p_a = p_b = p$ and

$$MAC_{a,b} \geq \frac{(r+1)^2}{p^2}, \quad (\text{A.7})$$

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